## Notice of References Cited Application/Control No. 10/516,297 Examiner LAWRENCE N. LARYEA Applicant(s)/Patent Under Reexamination SCHMIDT ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0243147	12-2004	Lipow, Kenneth I.	606/130
*	В	US-6,661,571	12-2003	Shioda et al.	359/372
*	С	US-2004/0254454	12-2004	Kockro, Ralf Alfons	600/424
*	D	US-5,792,147	08-1998	Evans et al.	606/130
*	Е	US-2001/0055062	12-2001	Shioda et al.	348/79
*	F	US-5,790,307	08-1998	Mick et al.	359/382
*	G	US-5,971,997	10-1999	Guthrie et al.	606/130
	Н	US-		1.5	
	-	US-	6		
	J	US-			
	К	US-	<b>1</b>		
	L	US-	1		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	_				ı.C.	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.